

# **MOSFET** - Power, Single **N-Channel** 40 V, 0.67 mΩ, 370 A

## **NVMFS5C404NL**

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS5C404NLWF Wettable Flank Option for Enhanced Optical
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage	)		V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	370	Α
Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C		260	
Power Dissipation	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	200	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		100	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	52	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C		37	
Power Dissipation	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.9	W
R <sub>θJA</sub> (Notes 1 & 2)		T <sub>A</sub> = 100°C		1.9	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	900	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to + 175	°C
Source Current (Body Diode)			IS	191	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 38 A)			E <sub>AS</sub>	907	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

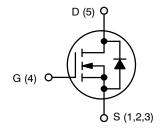
#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.75	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

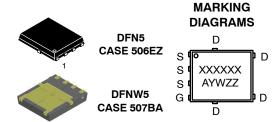
- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

1

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
40 V	0.67 m $\Omega$ @ 10 V	070 4	
40 V	1.0 mΩ @ 4.5 V	370 A	



**N-CHANNEL MOSFET** 



XXXXXX = Specific Device Code

= Assembly Location

= Year = Work Week W = Lot Traceability

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

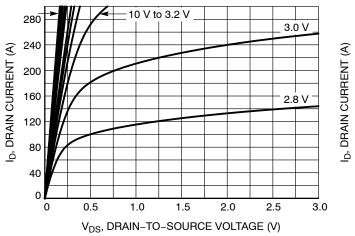
Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•		-	-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			٧
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				21.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10	,
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			250	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>G</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-6.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		0.52	0.67	0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		0.75	1.0	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub>	<sub>)</sub> = 50 A		270		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C <sub>ISS</sub>				12168		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			4538		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				79.8		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			81		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 2	20 V; I <sub>D</sub> = 50 A		181		1
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 50 A			8.5		nC
Gate-to-Source Charge	Q <sub>GS</sub>				27.8		1
Gate-to-Drain Charge	$Q_{GD}$				23.8		1
Plateau Voltage	$V_{GP}$				2.7		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				24		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	<sub>19</sub> = 20 V,		135		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 50 \text{ A}, R_G$	= 1.0 Ω		87		
Fall Time	t <sub>f</sub>				157		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS			•		•	•
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.7	1.2	
		$I_{S} = 50 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.61		V
Reverse Recovery Time	t <sub>RR</sub>				97.4		
Charge Time	ta	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			46.5		ns
Discharge Time	t <sub>b</sub>				50.9		1
Reverse Recovery Charge	Q <sub>RR</sub>				190		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

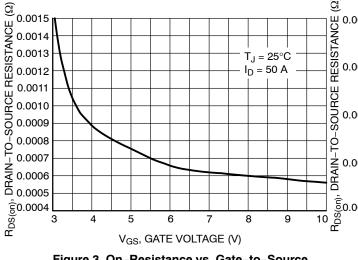
800



700 600 500 400 300  $T_J = 25^{\circ}C$ 200  $T_{J} = 125^{\circ}$ 100  $T_{.1} = -55^{\circ}C$ 0 0 0.5 2.0 3.0 3.5 1.0 1.5 2.5 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



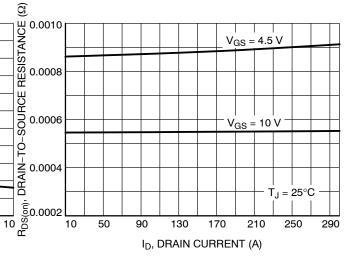
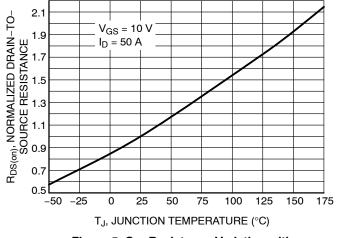


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



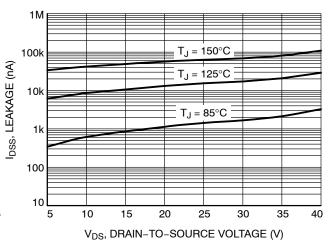
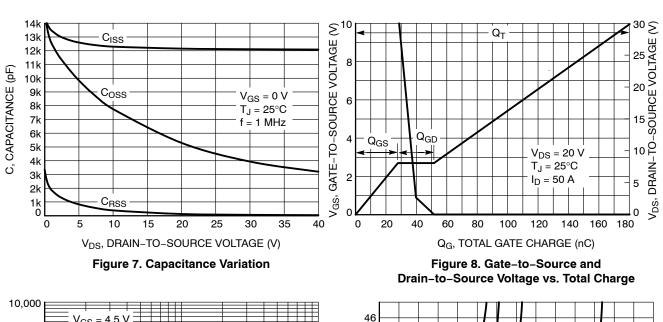


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**



46  $V_{GS} = 4.5 V$  $V_{DD} = 20 \text{ V}$ 41 SOURCE CURRENT (A) t, TIME (ns)  $I_{D} = 50 \text{ A}$ 36 31 26 21 16 11 6 10 10 100 0.3  $R_G$ , GATE RESISTANCE ( $\Omega$ )

Figure 9. Resistive Switching Time Variation vs. Gate Resistance

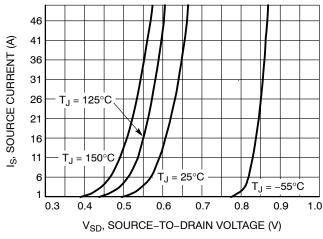


Figure 10. Diode Forward Voltage vs. Current

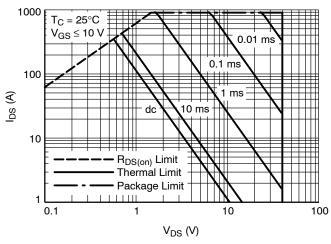


Figure 11. Safe Operating Area

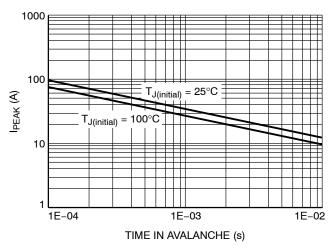


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

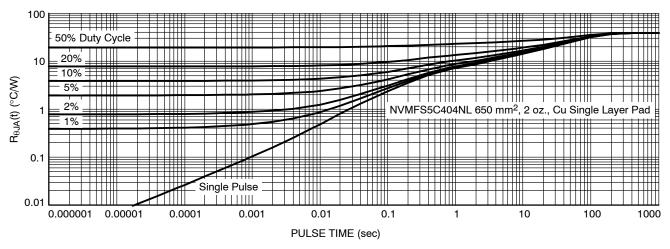


Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

Device	Case	Marking	Package	Shipping <sup>†</sup>
NVMFS5C404NLT1G	506EZ	5C404L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C404NLWFT1G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C404NLT3G	506EZ	5C404L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5C404NLWFT3G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel
NVMFS5C404NLAFT1G	506EZ	5C404L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C404NLWFAFT1G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel
NVMFS5C404NLAFT3G	506EZ	5C404L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5C404NLWFAFT3G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel
NVMFS5C404NLWFET3G	507BA	404LWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

SCALE 2:1





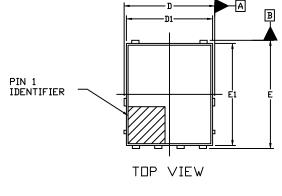
**DATE 25 AUG 2021** 

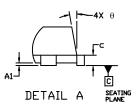
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
  2. CONTROLLING DIMENSION: MILLIMETERS
  3. DIMENSIONS DI AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, DR GATE BURRS.

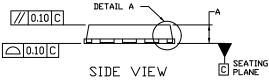
		MI	LLIMETE	25
	DIM	MIN.	N□M.	MAX.
-4X θ	Α	0.90	1.00	1.10
	A1	0.00		0.05
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	b	0.33	0.41	0.51
	С	0.23	0.28	0.33
t Y	D	5.00	5.15	5.30
DETAIL A SEATING PLANE	D1	4.70	4.90	5.10
FLANE	D2	3.80	4.00	4.20
	Е	6.00	6.15	6.30
	E1	5.70	5.90	6.10
	E2	3.45	3.80	3.85
	е		1.27 BSC	
i	G	0.51	0.575	0.71
	k	1.10	1.20	1.40
	L	0.51	0.575	0.71
	L1		0.125 RE	F
	М	3.00	3.40	3.80
	θ	0°		12*
2X (	0.4950 <del></del>	4.5	56 <del></del>	

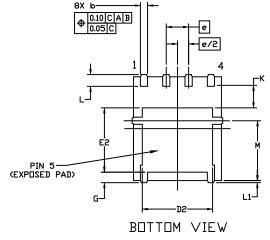
2X 0.25

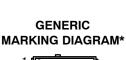
2X 0.91











PACKAGE DUTLINE





For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

XXXXXX = Specific Device Code = Assembly Location

Α Υ = Year

W = Work Week

ZZ = Lot Traceability

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■" may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON24855H	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED"	
DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

**IDENTIFIER** 





CASE 507BA **ISSUE A** 



**MILLIMETERS** 

N□M.

0.575

0.575

0.150 REF

1.35

MAX. 1.10 0.05 0.51

0.33

5.30 5.10

4.20

6.30 6.10

3.85

0.71

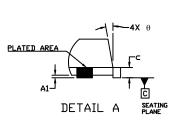
1.50

0.71



DIM

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
CONTROLLING DIMENSION: MILLIMETERS
DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH,
PROTRUSIONS, OR GATE BURRS.
THIS PACKAGE CONTAINS WETTABLE FLANK DESIGN
FEATURES TO AID IN FILLET FORMATION ON THE LEADS DURING MOUNTING.



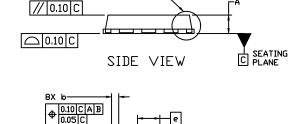
Α	0.90	1.00
A1	0.00	
b	0.33	0.41
С	0.23	0.28
D	5.00	5.15
D1	4.70	4.90
D2	3.80	4.00
Е	6.00	6.15
E1	5.70	5.90
E2	3.45	3.65
е		1.27 BSC

0.51

1.20

0.51

MIN



e/2

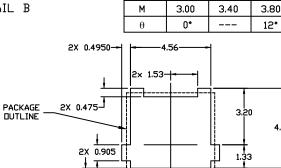
BOTTOM VIEW

-DETAIL B

DETAIL A

TOP VIEW





0.965

4X 1.00-

G

Κ

L1

#### **GENERIC** MARKING DIAGRAM\*

PIN 5 (EXPOSED PAD)



= Assembly Location Α

Υ = Year W

ZZ

= Work Week = Lot Traceability

XXXXXX = Specific Device Code \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products

may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the  $\square N$ Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON26450H
DOGGINEITI ITOMBEITI	3070112040011

Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

4X 0.75

**DESCRIPTION:** DFNW5 5x6 (FULL-CUT SO8FL WF) **PAGE 1 OF 1** 

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

#### ADDITIONAL INFORMATION

**TECHNICAL PUBLICATIONS:** 

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales